

# L-Band, GaN/SiC, RF Power Transistor

1030 and 1090 MHz | 25 W typ | 55% Efficiency typ | 19.5 dB Gain typ | 50 V | 128μs Pulse Length, 2% Duty Cycle

IGN1011M15 and IGN1011M15S are high power GaN-on-SiC RF power transistors that have been designed to suit the unique needs of IFF/SSR avionics systems. They operate at 1030 and 1090 MHz. Under 128 $\mu$ s, 2% duty-cycle pulse conditions, they supply a minimum of 15W of peak output power, with typically 19.5dB of associated gain and 55% efficiency. They operate from a 50 V supply voltage. For optimal thermal efficiency, the transistors are housed in a metal-based package with an epoxy-sealed ceramic lid.



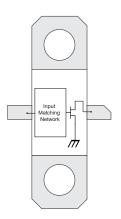


## **FEATURES**

- GaN on SiC HEMT Technology
- Output Power >15 W
- Pre-matched Input Impedance
- 100% RF Tested Under 128μs, 2% duty-cycle pulse conditions
- RoHS and REACH Compliant

#### **APPLICATIONS**

- L-band Avionics IFF & SSR Systems
- Suitable for both uplink and downlink (Transponder)



**Table 1. Absolute Maximum Ratings (Not Simultaneous)** 

Parameter	Symbol	Value	Units	Test Conditions
DC Drain-Source Voltage	V <sub>DS</sub>	150	V	25 °C
DC Gate-Source Voltage	V <sub>GS</sub>	-8 to +1.0	V	25 °C
DC Drain Current	I <sub>D</sub>	1.8	A	25 °C
DC Gate Current	I <sub>G</sub>	1.8	mA	25 °C
RF Input Power	P <sub>REIN</sub>	25	W	25 °C
Operating Junction Temperature	T <sub>j</sub>	-55 to +200	°C	
Storage Temperature	T <sub>STG</sub>	-55 to +150	°C	
Soldering Temperature	T <sub>SOLDER</sub>	260 for 60s	°C	

Note: Operation outside the limits given in this table may cause permanent damage to the transistor

Table 2. DC Electrical Characteristics (Case temperature = 25 °C unless otherwise stated)

Parameter	Symbol	Min	Тур	Max	Units	Test Conditions
Gate Pinch-Off Voltage	V <sub>P</sub>	-5.0			V	$V_{DS} = 50V$ , $I_{DS} = 1mA$
Quiescent Gate Voltage	V <sub>Q</sub>		-2.5		V	$V_{DS} = 50V, I_{DS} = 10mA$



Table 3. RF Electrical Characteristics (Case temperature = 30 °C unless otherwise stated)

Parameter	Symbol	Min	Тур	Max	Units	Test Conditions	
RF Output Power	P <sub>IN, RF</sub>	15	25	35	W	P <sub>IN</sub> =0.3W	
Gain	G	17	19.5	20.7	dB	f = 1030, 1090 MHz	
Drain Efficiency	η	45	55	65	%	128µs, 2% duty-cycle pulse conditions	
Pulse Droop	D	-0.3	-0.2	+0.2	dB		
Input Return Loss	IRL	10	12	18	dB	$V_{DS} = 50V, I_{DS} = 10mA$	
Load Mismatch Stability	VSWR-S	2:1					
VSWR Withstand	VSWR-LMT	5:1					

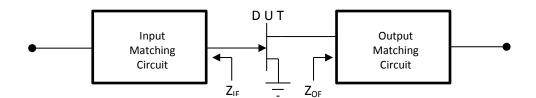
Note: Consult Integra Technologies Application Note 001 for information on how RF output power and pulse droop are measured for the ELM pulse train.

Table 4. Thermal Resistance (Case temperature = 25 °C unless otherwise stated)

Parameter	Symbol	Min	Тур	Max	Units	Test Conditions
Peak Thermal Resistance, Channel to Case	R <sub>TH(JC)</sub>			5.5	°C/W	$P_{out}$ = 15W Efficiency = 55% f = 1030, 1090 MHz 128 $\mu$ s, 2% duty-cycle pulse conditions $V_{DS}$ = 50V, $I_{DS}$ = 10mA

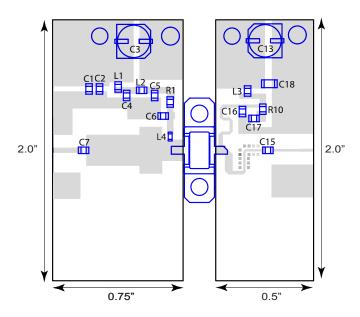
Table 5. Optimum Source & Load Impedances (Case temperature = 25 °C unless otherwise stated)

Frequency (MHz)	Z <sub>IF</sub>	Z <sub>of</sub>	Units	Test Conditions
1030	1.8 - j 1.0	24.0 + j 13.8	Ω	P <sub>out</sub> = 15W 128µs, 2% duty-cycle pulse conditions
1090	1.8 - j 0.36	27.2 + j 11.6	Ω	$V_{DS} = 50V, I_{DS} = 10mA$





## **TEST FIXTURE**

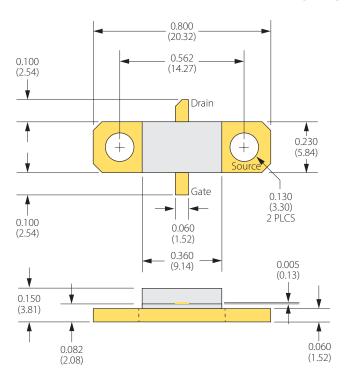


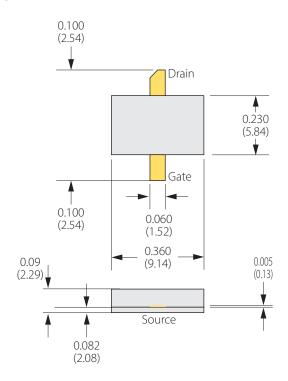
# **Bill of Materials for IGN1011M15 Test Fixture**

Designator	Description	Part Number	
C1, C4, C17	CAP 0.1µF, 0805, 50V, X7R	08051C104K4T2A	
C2, C5	CAP 1000pF, 0805	08051A102J4T2A	
C3	CAP 47μF, 25V, Electrolytic	PCV1E470MCL2GS	
C6, C15, C16	CAP 18pF, 0805	600F180JT250XT	
C7	CAP 9.1pF, 0603	600S9R1BT250XT	
C13	CAP 68μF, 63V, Electrolytic	EEE-FK1J680P	
C18	CAP 1μF, 1206, 50V, X7R	12061C105K4T2A	
L1, L2, L3	IND, FB, 120 OHM, 0805, 5A	ILHB0805ER121V	
L4	IND 120nH, 0603	0603HP-12XJB	
R1, R10	RES, 5.1 OHM, 0805	ERJ-6GEYJ5R1V	
PC Board Type	ROGERS RT6010, 25mil, 1/1oz. Copper		



## **PACKAGE PL32A2**





**BOLT-DOWN FLANGE OPTION** IGN1011M15

**EARLESS FLANGE OPTION** IGN1011M15S

**Dimensions: Inches (mm)** 



#### **ESD & MSL Rating**

Parameter	Rating	Standard	
ESD Human Body Model (HBM)	TBD	ESDA/JEDEC JS-001-2012	
ESD Charged Device Model (CDM) TBD		JEDEC JESD22-C101F	
Moisture Sensitivty Level (MSL)	Unlimited Shelf Life	IPC/JEDEC J-STD-020	

## **RoHS Compliance**

Integra Technologies, Inc declares that its GaN and LDMOS Transistor Products comply with EU Directive 2011/65/EU on the restriction of the use of certain hazardous substances in electrical and electronic equipment (RoHS2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863/EU.

#### **REACH Compliance**

Integra Technologies supports EU Regulation number 1907/2006 concerning the Registration, Evaluation, Authorization, and Restriction of Chemicals (REACH) as these apply to Integra semiconductor products, development tools, and shipping packaging.

In support of the REACH regulation, Integra will:

- Inform customers and recipients of Integra product if they contain any substances that are of very high concern (SVHC) per the European Chemical Agency (ECHA) website.
- Notify ECHA if any Integra product that contains any SVHCs which exceed guidelines for REACH chemicals by weight per part number and for total content weight per year for all products produced in or imported to the European market.
- •Cease shipments of product containing REACH Annex XIV substances until authorization has been obtained.
- Cease shipment of product containing REACH Annex XVII chemicals when restrictions apply.

Integra has evaluated its materials, BOMs, and product specifications and product and has determined that this transistor conforms to all REACH and SVHC regulations and guidelines. Integra has implemented actions and control programs that will assure continued compliance.

### Disclaimer

Integra Technologies Inc. reserves the right to make changes without further notice to any products herein. Integra Technologies Inc. makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Integra Technologies Inc. assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. Integra Technologies Inc. products are not designed for use in life support appliances, devices, or systems where malfunction of these products can reasonably be expected to result in personal injury. Integra Technologies Inc. customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Integra Technologies Inc. for any damages resulting from such improper use or sale.

DATA SHEET STATUS

Advanced Specification - This data sheet contains Advanced specifications.

Preliminary Specification - This data sheet contains specifications based on preliminary measurements and data.

Final Specification - This data sheet contains final product specifications.

MAXIMUM RATINGS Stress above one or more of the maximum ratings may cause permanent damage to the device. These are maximum ratings only operation of the device at these or at any other conditions above those given in the characteristics sections of the specification is not implied. Exposure to maximum values for extended periods of time may affect device reliability.Integra Technologies, 321 Coral Circle, El Segundo, CA 90245-4620 | Phone: 310-606-0855 | Fax: 310-606-0865